

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/064,251	LI ET AL.	
Examiner	Art Unit	
HABTE MERED	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
370	221-223	8/24/2007	НМ	
370	216-218	8/24/2007	НМ	
370	225,227	8/24/2007	НМ	
370	228	8/24/2007	НМ	
370	241,242	8/24/2007	НМ	
370	244	8/24/2007	НМ	
370	250,400	8/24/2007	НМ	
370	401,406	8/24/2007	НМ	
714	100,1,2	8/24/2007	НМ	
709	239	8/24/2007	НМ	
379	221.1	8/24/2007	НМ	
379	221.04	8/24/2007	НМ	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched East DB:USPAT, UPGPUB, JPO, EPO	8/24/2007	НМ		
IEEE	8/24/2007	НМ		
Palm Inventor's DB	8/24/2007	НМ		
Consulted John Pezzlo (Primary) on search strategy and rejection strategy	8/24/2007	НМ		
Consulted Doris (SPE) To on srejection strategy	8/28/2007	НМ		